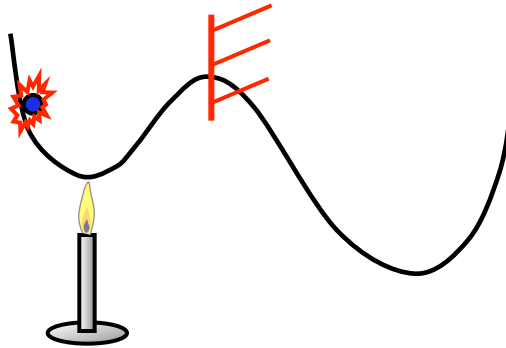


Temperature Accelerated Dynamics



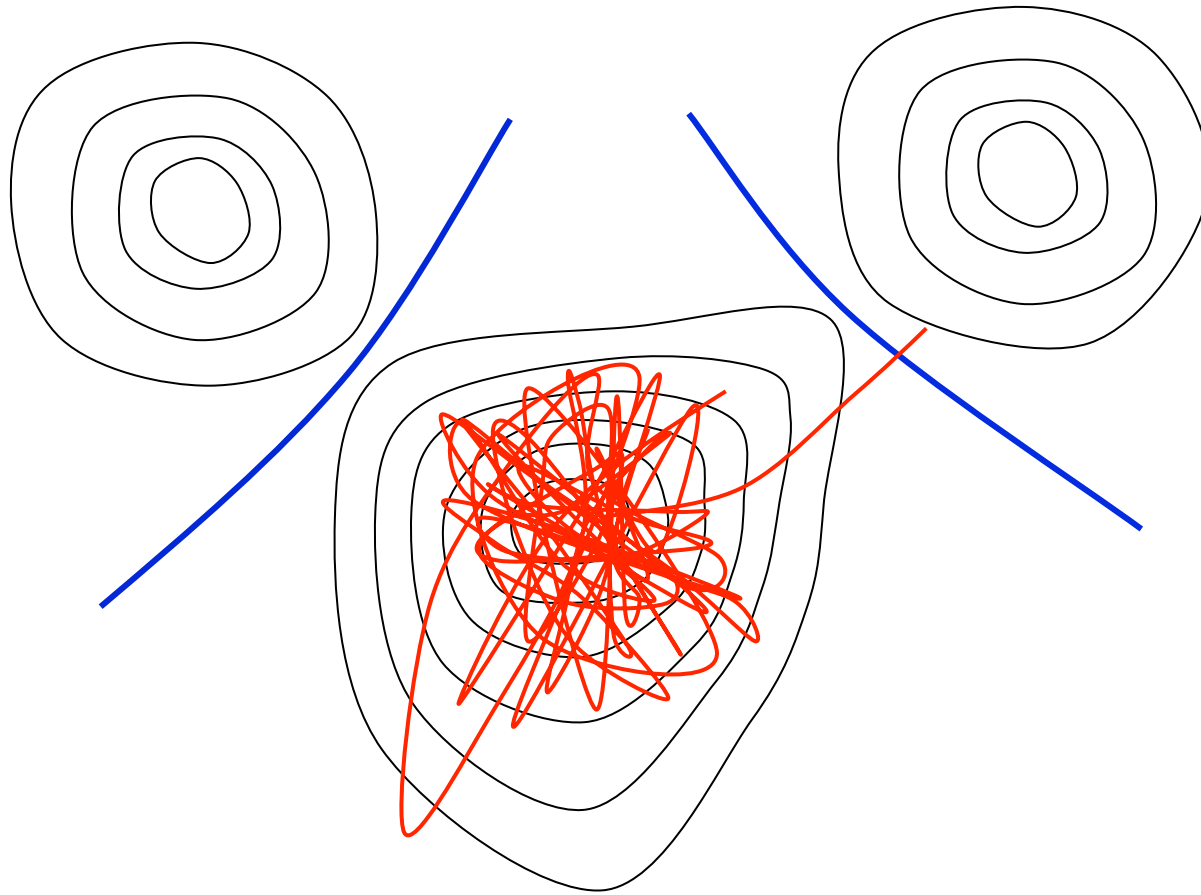
A very brief introduction

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Infrequent-Event System



The system vibrates in 3-N dimensional basin many times before finding an escape path. In temperature accelerated dynamics (TAD), we raise the temperature to quickly find a few escape events. Using temperature extrapolation, we determine which event would have happened first at the low temperature.

Temperature Accelerated Dynamics (TAD)

Concept:

Raise temperature of system to make events occur more frequently. Filter out the events that should not have occurred at the lower temperature.

Assumptions:

- infrequent-event system
- transition state theory (no correlated events)
- harmonic transition state theory (gives Arrhenius behavior)

$$k = \nu_0 \exp[-\Delta E/k_B T]$$

- all preexponentials (ν_0) are greater than ν_{\min}

[Sørensen and Voter, J. Chem. Phys. 112, 9599 (2000)]

TAD Procedure

- Run MD at elevated temperature (T_{high}) in state A.
- Intercept each attempted escape from basin A
 - find saddle point (and hence barrier height)
(e.g., using nudged elastic band method of Jonsson et al).
 - extrapolate to predict event time at T_{low} .
- Reflect system back into basin A and continue.
- When safe, accept transition with shortest time at T_{low} .
- Go to new state and repeat.

TAD temperature-extrapolated time

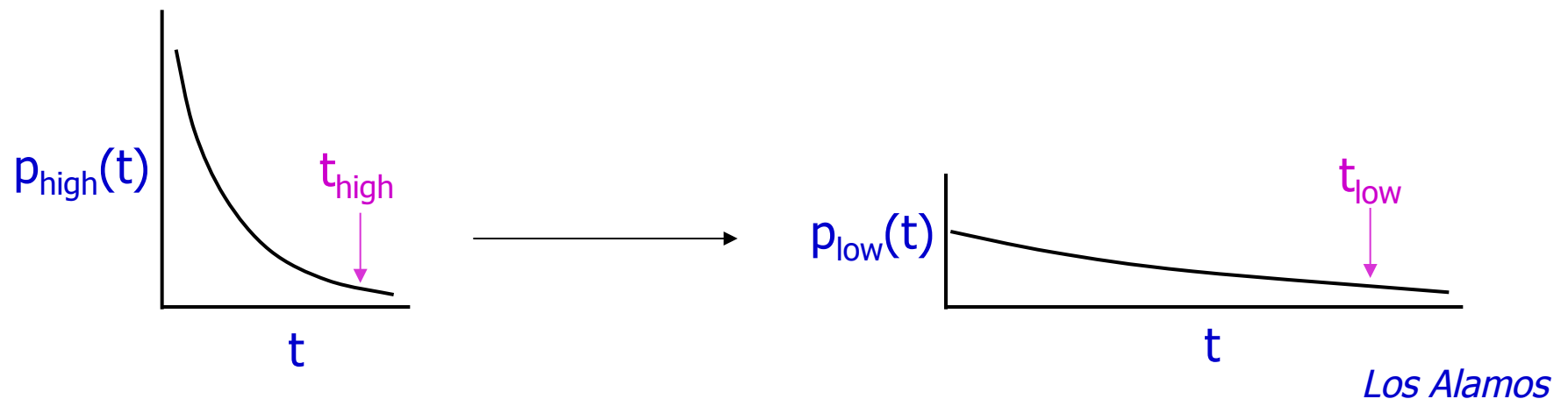
Because each rate is assumed to be Arrhenius,

$$k = \nu_0 \exp[-\Delta E/k_B T] ,$$

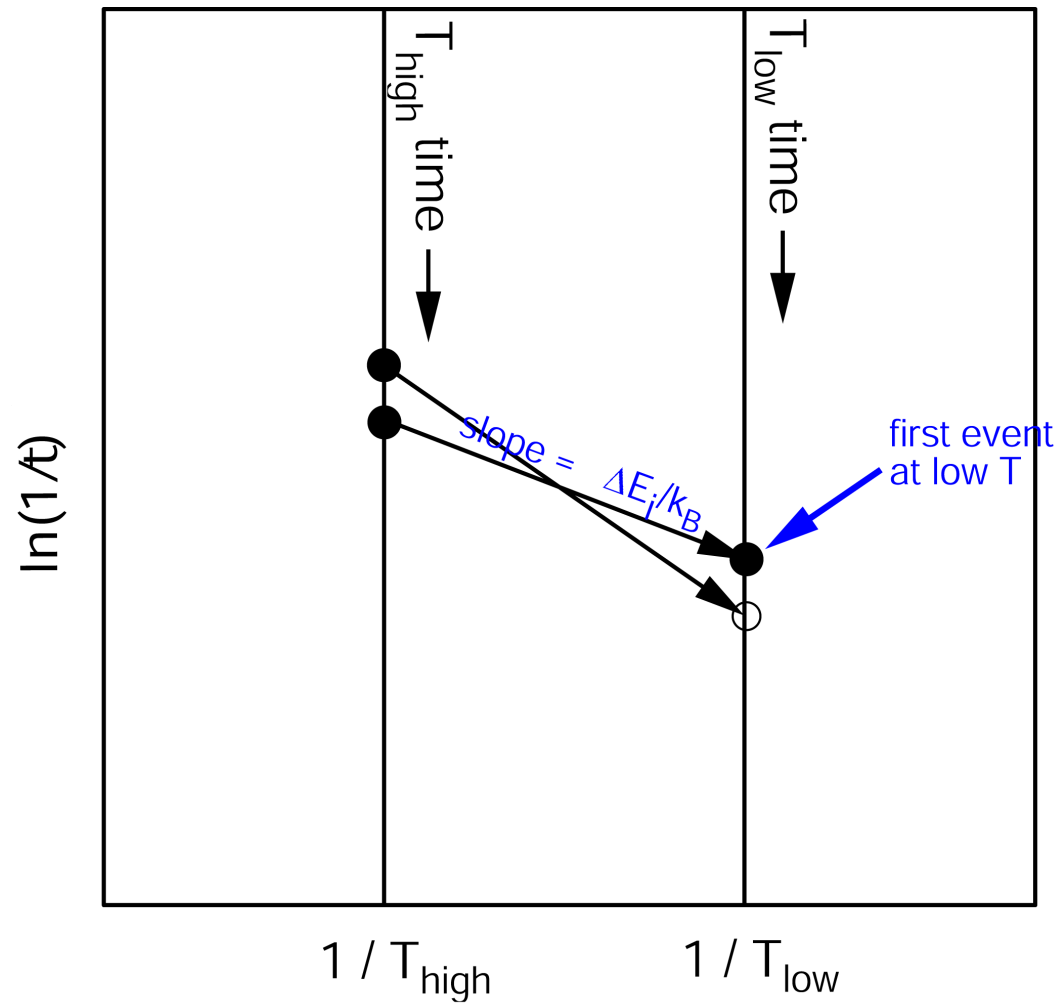
the time for each particular event at high T can be extrapolated to low T:

$$t_{\text{low}} = t_{\text{high}} \exp[\Delta E(1/k_B T_{\text{low}} - 1/k_B T_{\text{high}})] .$$

This time is sampled correctly from the exponential distribution at low T, mapped from the high T sample:



The Arrhenius view



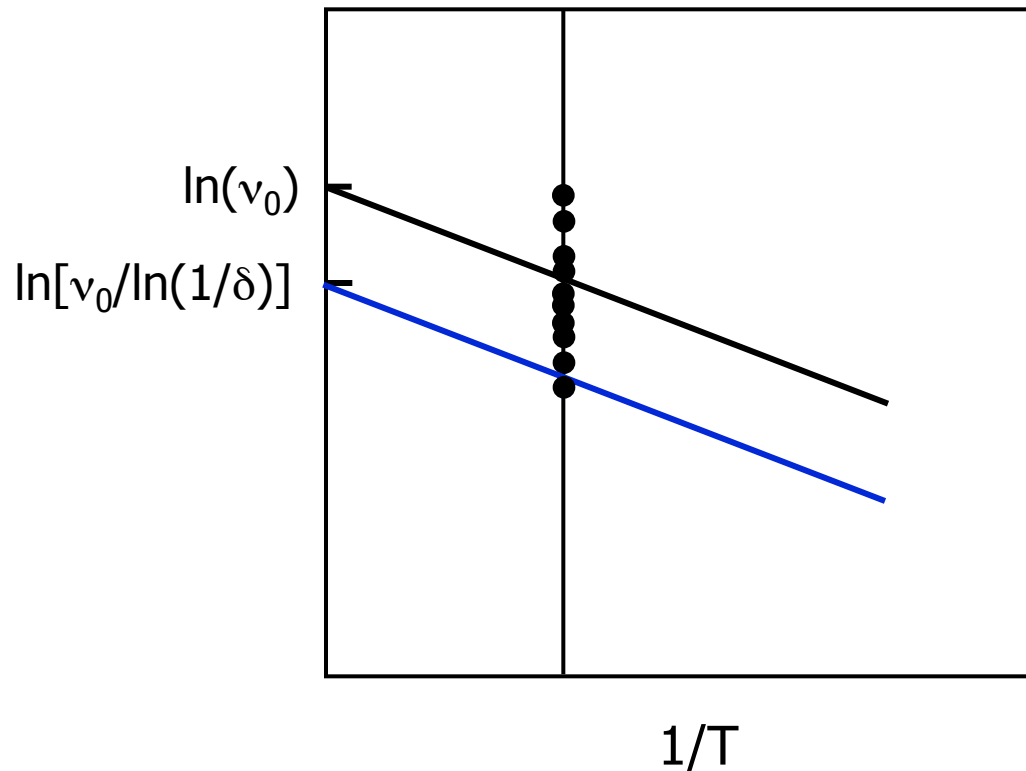
when can we stop?

The confidence line

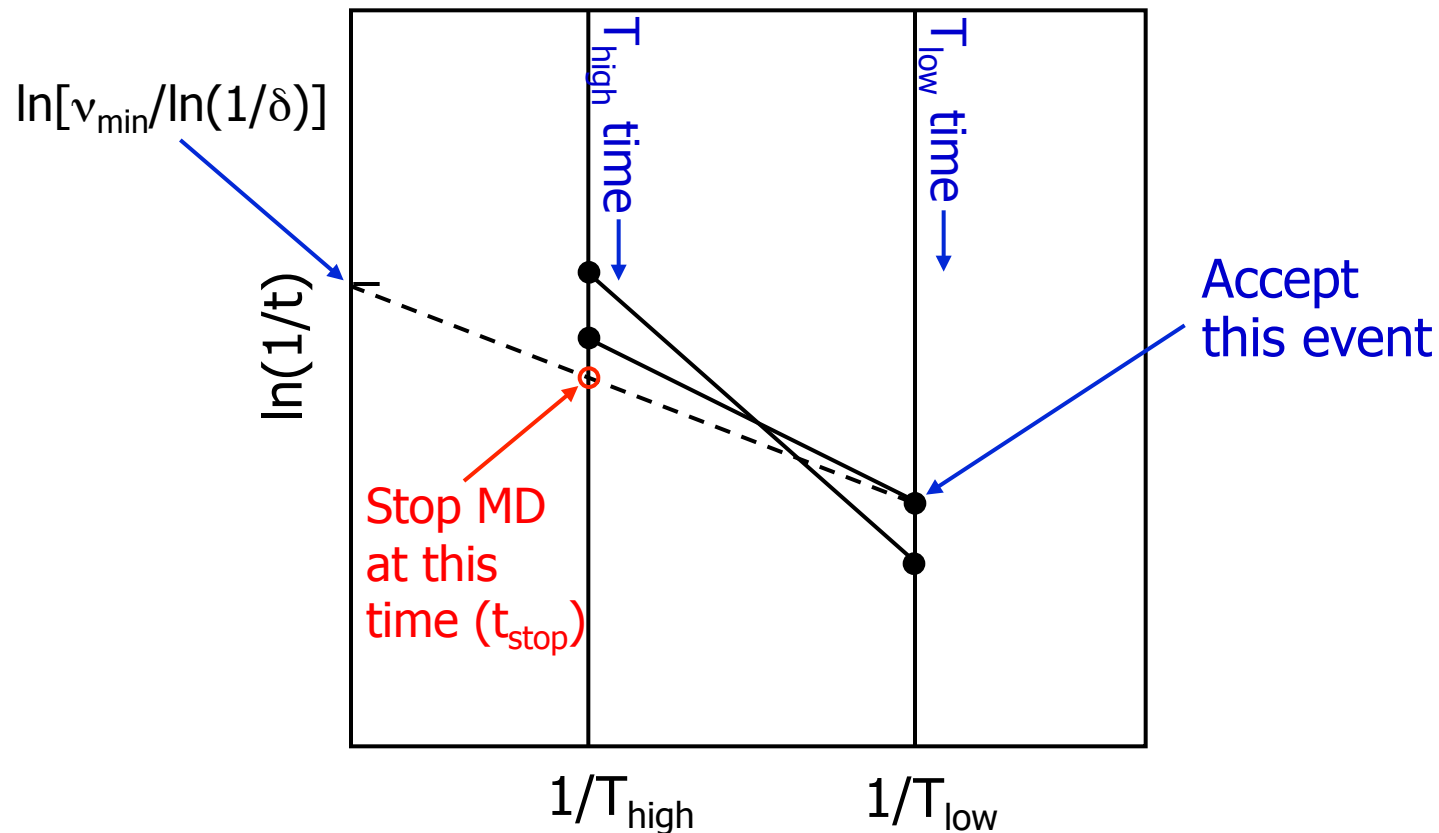
For a pathway with rate k , the time τ required to be certain with confidence $1-\delta$ that at least one escape will occur is given by

$$\tau = (1/k) \ln(1/\delta)$$

For an Arrhenius rate, $k = \nu_0 \exp(-E_a/k_B T)$, all but fraction δ of the first escapes will occur above the line with slope E_a and intercept $\ln[\nu_0/\ln(1/\delta)]$



TAD - when can we stop the MD and accept an event?



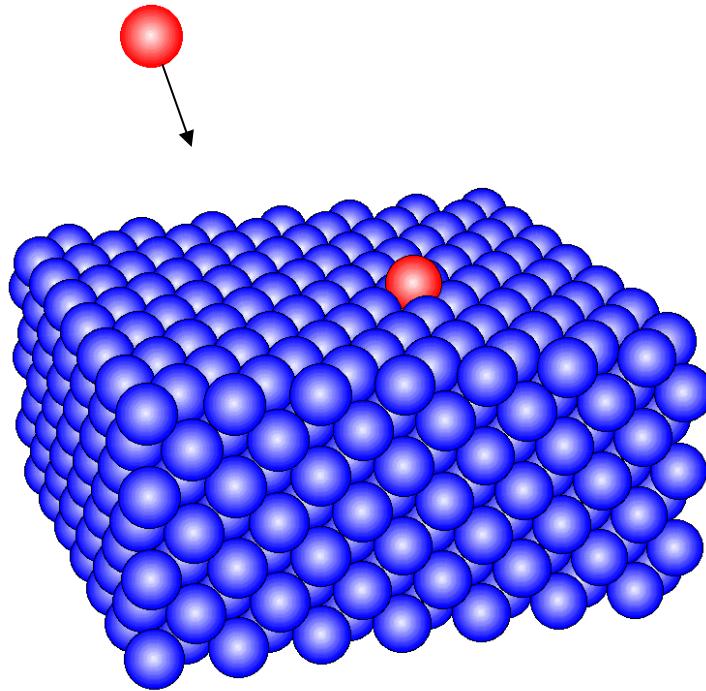
After time t_{stop} , with confidence $1-\delta$, no event can replace shortest-time event seen at low T .

Move system to this state and start again.

Exact dynamics, assuming harmonic TST, v_{min} , uncertainty δ .

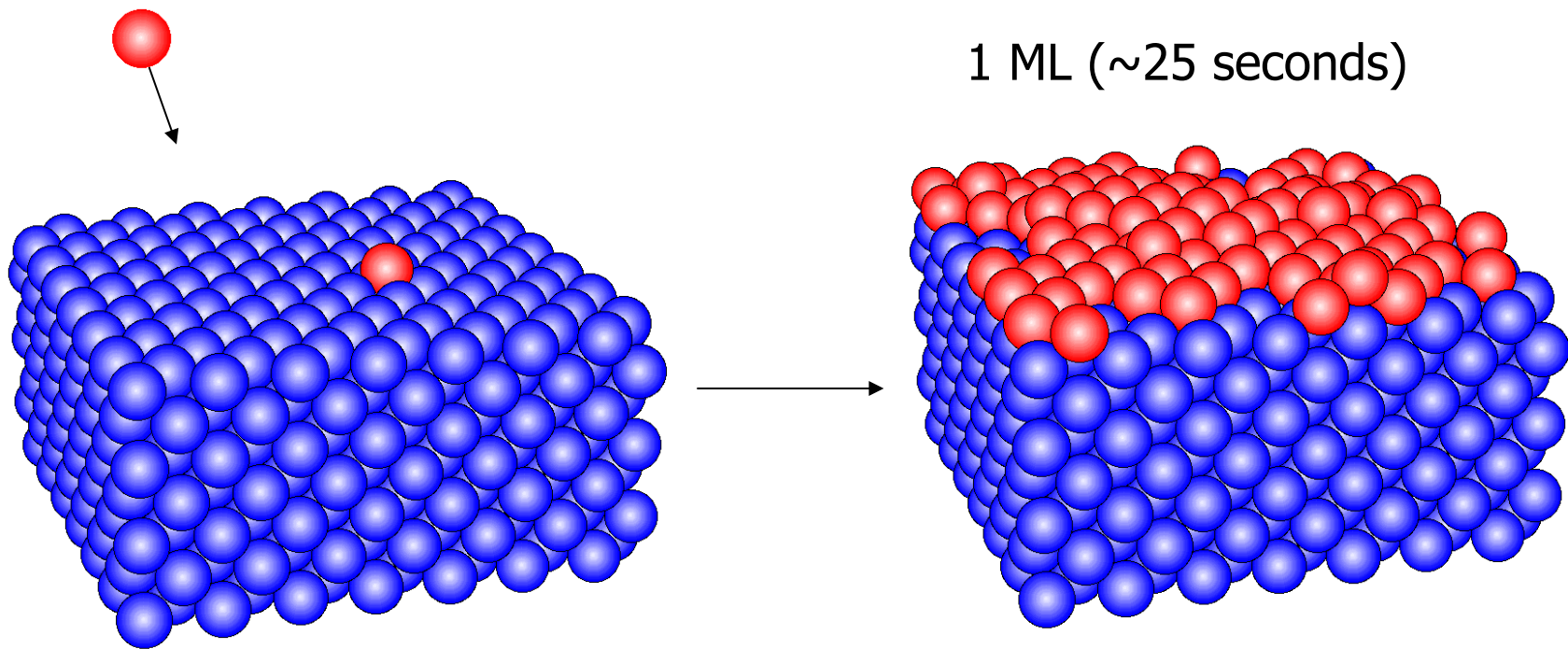
MD+TAD metal deposition simulation

- MD for each deposition event (2 ps)
- TAD for intervening time (~ 1 s)
- Embedded atom method (EAM) for fcc metals



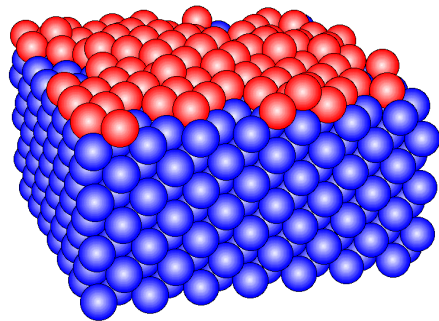
MD+TAD deposition of Cu/Ag(100)

$T=77\text{K}$, flux= 0.04 ML/s, matching deposition conditions of Egelhoff and Jacob (1989).

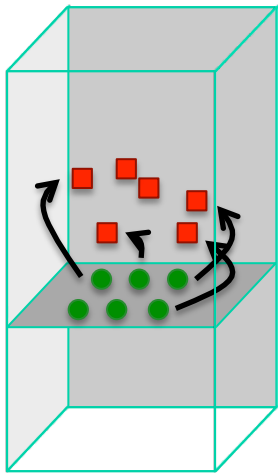


Second-layer Cu atoms exhibit novel mobility at $T=77\text{K}$, due to epitaxial strain of Cu on Ag(100).

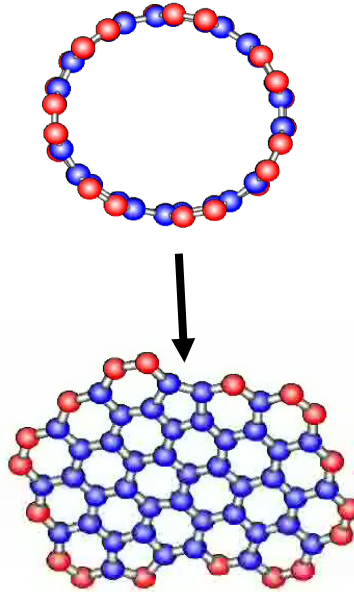
Examples of TAD Studies



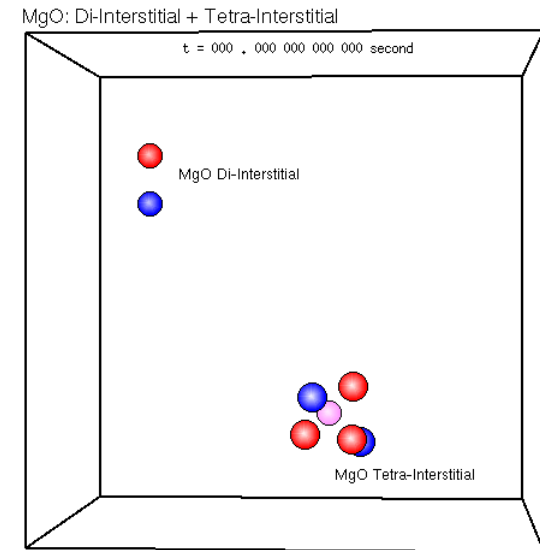
Cu/Ag(100), 1 ML/25 s
T=77K, Sprague et al, 2002.



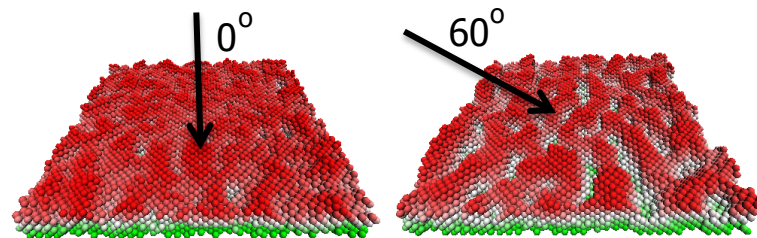
Interstitial emission from
GB after cascade, μ s,
Bai et al, Science, 2010.



Annealing nanotube
slices, μ s, Uberuaga
et al, 2011.



Interstitial defects in MgO,
ps – s, Uberuaga et al, 2004.



Growth of Cu(001), MD+ParTAD,
5 ML/ms, Shim, Amar et al, 2008.